UNITE	D STATES PATENT A	and Trademark Office	UNITED STATES DEPART United States Patent and T Address: COMMISSIONER OF P. Washington, D.C. 20231 www.uspta.gov	rademark Office ATENTS AND TRADEMARKS
APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/863,223	05/24/2001	Chung-Shi Liu	TS00-488	9868
28112 7590 12/31/2002 GEORGE O. SAILE & ASSOCIATES			EXAMINER	
28 DAVIS AVI POUGHKEEPS	ENUE		COLEMAN, WILLIAM D	
			ART UNIT	PAPER NUMBER
			2823	
		DATE MAILED: 12/31/2002		

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)	
	09/863,223	LIU ET AL.	,
Office Action Summary	Examiner	Art Unit	
	W. David Coleman	2823	
The MAILING DATE of this communication a Period for Reply	ppears on the cover sheet with	the correspondence address	
A SHORTENED STATUTORY PERIOD FOR REP THE MAILING DATE OF THIS COMMUNICATION - Extensions of time may be available under the provisions of 37 CFR after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a re - If NO period for reply is specified above, the maximum statutory period - Failure to reply within the set or extended period for reply will, by stat - Any reply received by the Office later than three months after the mail earned patent term adjustment. See 37 CFR 1.704(b).	I. 1.136(a). In no event, however, may a repl eply within the statutory minimum of thirty ( dwill apply and will expire SIX (6) MONTH ute cause the application to become ABA	y be timely filed 30) days will be considered timely. IS from the mailing date of this communic NDONED (35 U.S.C. § 133).	cation.
Status			
1) Responsive to communication(s) filed on <u>1</u>			
	This action is non-final.		
3) Since this application is in condition for allo closed in accordance with the practice under	wance except for formal matte er <i>Ex parte Quayle</i> , 1935 C.D.	ers, prosecution as to the me 11, 453 O.G. 213.	rits is
Disposition of Claims			
4) Claim(s) <u>1-22</u> is/are pending in the application			
4a) Of the above claim(s) <u>13-22</u> is/are withdr	awn from consideration.		
5) Claim(s) <u>5-12</u> is/are allowed.			
6) Claim(s) <u>1-4</u> is/are rejected.			
7) Claim(s) is/are objected to.	las election requirement		
8) Claim(s) are subject to restriction and Application Papers	i/or election requirement.		
9) The specification is objected to by the Exami			
10)  The drawing(s) filed on is/are: a)  □ ac			
Applicant may not request that any objection to			
11) The proposed drawing correction filed on		approved by the Examiner.	
If approved, corrected drawings are required in			
12) The oath or declaration is objected to by the	Examiner.		
Priority under 35 U.S.C. §§ 119 and 120			
13) Acknowledgment is made of a claim for fore	ign priority under 35 U.S.C. §	119(a)-(d) or (f).	
a) All b) Some * c) None of:			
1. Certified copies of the priority docume	ents have been received.		
2. Certified copies of the priority docume			
3. Copies of the certified copies of the p application from the International * See the attached detailed Office action for a I	Bureau (PCT Rule 17.2(a)).		e
14) Acknowledgment is made of a claim for dome	estic priority under 35 U.S.C. §	119(e) (to a provisional app	ication).
a) [] The translation of the foreign language 15)[] Acknowledgment is made of a claim for dome	provisional application has be estic priority under 35 U.S.C. {	en received. §§ 120 and/or 121.	
Attachment(s)			
<ol> <li>1) X Notice of References Cited (PTO-892)</li> <li>2) Notice of Draftsperson's Patent Drawing Review (PTO-948)</li> <li>3) X Information Disclosure Statement(s) (PTO-1449) Paper Note</li> </ol>	5) 🔲 Notice of In	ummary (PTO-413) Paper No(s) formal Patent Application (PTO-152	

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#### **DETAILED ACTION**

#### **Election/Restrictions**

1. Claims 13-22 withdrawn from further consideration pursuant to 37 CFR 1.142(b), as

being drawn to a nonelected invention, there being no allowable generic or linking claim.

Applicant timely traversed the restriction (election) requirement in Paper No. 4.

## Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(e) the invention was described in a patent granted on an application for patent by another filed in the United States before the invention thereof by the applicant for patent, or on an international application by another who has fulfilled the requirements of paragraphs (1), (2), and (4) of section 371(c) of this title before the invention thereof by the applicant for patent.

3. The changes made to 35 U.S.C. 102(e) by the American Inventors Protection Act of 1999 (AIPA) do not apply to the examination of this application as the application being examined was not (1) filed on or after November 29, 2000, or (2) voluntarily published under 35 U.S.C. 122(b). Therefore, this application is examined under 35 U.S.C. 102(e) prior to the amendment by the AIPA (pre-AIPA 35 U.S.C. 102(e)).

4. Claim 1 is rejected under 35 U.S.C. 102(e) as being anticipated by Tsai et al., U.S. Patent 6,319,814 B1..

5. Tsai discloses a semiconductor process as claimed. See FIGS. 2A-2H, and column 2,

lines 23-30, where <u>Tsai</u> teaches a process for filling a via hole in a layer of FSG, having an upper surface,

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comprising the sequential steps of:

depositing the layer of FSG on a substrate;

depositing a layer of USG on the upper surface-,

patterning and then etching said USG and FSG layers, whereby a via hole, having

walls and extending as far as the substrate, is formed;

depositing a seed layer on the walls of the via hole; and

overfilling the via hole with a material,, removing said material until

by means of CMP aid USG layer is reached.

## Claim Rejections - 35 USC § 103

6. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 2 and 3 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tsai et al.,U.S. Patent 6,319,814 B1.

8. Pertaining to claims 2 and 3, <u>Tsai</u> fails to teach the thickness of the FSG with the claimed atomic percentage of fluorine and the thickness of the USG as claimed. Given the teaching of the references, it would have been obvious to determine the optimum thickness, temperature as well as condition of delivery of the layers involved. See *In re Aller, Lacey and Hall* (10 USPQ 233-237) "It is not inventive to discover optimum or workable ranges by routine experimentation. Note that the specification contains no disclosure of either the critical nature of

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based upon particular chosen dimensions or upon another variable recited in a claim, the

Applicant must show that the chosen dimensions are critical. In re Woodruff, 919 f.2d 1575,

1578, 16 USPQ2d 1934, 1936 (Fed. Cir. 1990).

Any differences in the claimed invention and the prior art may be expected to result in some differences in properties. The issue is whether the properties differ to such an extent that the difference is really unexpected. *In re Merck & Co.*, 800 F.2d 1091, 231 USPQ 375 (Fed. Cir. 1986)

Appellants have the burden of explaining the data in any declaration they proffer as evidence of non-obviousness. *Ex parte Ishizaka*, 24 USPQ2d 1621, 1624 (Bd. Pat. App. & Inter. 1992).

An Affidavit or declaration under 37 CFR 1.132 must compare the claimed subject matter with the closest prior art to be effective to rebut a prima facie case of obviousness. *In re Burckel*, 592 F.2d 1175, 201 USPQ 67 (CCPA 1979).

9. Claim 4 is rejected under 35 U.S.C. 103(a) as being unpatentable over Tsai et al, U.S.

Patent 6,319,814 B1 as applied to claims 1, 2 and 3 above, and further in view of Lee et al., U.S.

Patent 6,103,601.

10. Tsai fails to teach the process described in claim 1 wherein the step of depositing the

USG layer further comprises using PECVD from silane or TEOS at about 400 °C. Lee teaches

the process wherein the step of depositing the USG layer further comprises using PECVD from

silane or TEOS at about 400<sup>o</sup>C. In view of Lee, it would have been obvious to one of ordinary

skill in the art to incorporate the process step of Lee into the Tsai semiconductor process because

the USG layer can be deposited in a separate processing chamber from the FSG layer (column 7,

lines 51-63).

# Claim Rejections - 35 USC § 112

11. Claim 1 rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention. Applicant claims depositing a layer of USG on the upper surface, it is not clear if the upper surface is the substrate or the FSG layer.

12. Correction is required.

# Allowable Subject Matter

13. Claims 5-12 allowed.

14. The following is an examiner's statement of reasons for allowance: prior art does not anticipate nor render obviousness as to a process for forming a single damascene connector, comprising the sequential steps of:

providing a partially completed integrated circuit and then depositing thereon a layer of FSG having an upper surface'

depositing a layer of USG on said upper surface;

on the USG layer, depositing a layer of silicon oxynitride for use as an anti-reflection coating;

patterning and then etching said oxynitride, USG, and FSG layers, thereby forming a via hole extending as far as said integrated circuit;

depositing a barrier layer on the walls of the vial hole;

depositing a copper seed layer on the said barrier layer;

overfilling the vial hole with copper; and

by means of CMP, removing the copper until said USG layer is reached, thereby forming said damascene connector.

15. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

#### Conclusion

16. Any inquiry concerning this communication or earlier communications from the examiner should be directed to W. David Coleman whose telephone number is 703-305-0004.The examiner can normally be reached on 9:00 AM-5:00 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Olik Chaudhuri can be reached on 703-306-2794. The fax phone numbers for the organization where this application or proceeding is assigned are 703-308-7722 for regular communications and 703-308-7721 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-308-0956.

W. David Coleman Examiner Art Unit 2823

WDC December 27, 2002